

<b>Notice of References Cited</b>	Application/Control No. 10/647,762	Applicant(s)/Patent Under Reexamination HAN ET AL.	
	Examiner Paul D. Kim	Art Unit 3729	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,693,769	02-2004	Hsu et al.	360/317
	C	US-6,687,083	02-2004	Hsiao et al.	360/126
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	N	JP 01256107 A	10-1989	Japan	SUGIMOTO et al.	H01F 05/08
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	U	"Design and performance of a recessed thin film inductive transducer"; Zak, B.S.; Curland, N.; Giusti, J.H.; Ash, K.P.; Cameron, G.P.; Magnetics, IEEE Transactions on Volume 32, Issue 1, Jan. 1996; Page(s):74 - 79.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.